

<b>Notice of References Cited</b>	Application/Control No. 09/584,576	Applicant(s)/Patent Under Reexamination GRAUMANN, DAVID L.	
	Examiner Daniel Swerdlow	Art Unit 2644	Page 1 of 1

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	U	STMicroelectronics, ST75C530/ST75C540 SPECIFICATION, February 1999, pp. 1, 15, 17
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\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)  
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.

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